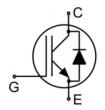


Main Product Characteristics:

Vces	1250V
Ic	50A
V _{CE(sat)}	1.9V





TO-247

Schematic Diagram

Features and Benefits:

- Trench FS technology offering
- High speed switching
- Low gate charge and V_{CE(sat)}
- High ruggedness, temperature stable behavior
- Maximum junction temperature 175°C



Applications:

- Solar Inverters
- Uninterruptible power supplies
- Motor drives
- Air condition

Absolute Max Rating:

Symbol	Parameter	Value	Units
Vces	Collector-Emitter Voltage	1250	V
V _{GES}	Gate- Emitter Voltage	±30	V
	Collector Current	100	
lc	Collector Current @T _C = 100 °C	50	
I _{Cpuls}	Pulsed Collector Current, tp limited by T _{jmax}	200	
-	Turn off safe operating area,V _{CE} =1200V,T _J =175°C	200	Α
lF	Diode Continuous Forward Current @Tc = 100 °C	50	
Ігм	Diode Maximum Forward Current	200	
Б	Power Dissipation @ T _C = 25°C	468	W
P _D	Power Dissipation @ T _C = 100°C	234	W
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to +175	°C
T∟	Maximum Temperature for Soldering	260	°C



Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
D	Thermal Resistance,Junction-to-case for IGBT	_	0.32	°C/W
R _{eJC}	Thermal Resistance,Junction-to-case for Diode	_	0.61	°C/W
R _{θJA}	Thermal Resistance,Junction-to-ambient	_	40	°C/W

Electrical Characteristics $@T_A=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions	
V(BR)CES	Collector-Emitter Breakdown Voltage	1250	_	_	V	Vge=0V,Ice=1mA	
V	Collector Emitter Seturation Voltage	_	1.9	2.1	.,	Ic=50A ,VgE=15V @T _J =25°C	
VCE(sat)	Collector-Emitter Saturation Voltage	_	2.38	_	V	Ic=50A ,VgE=15V @T _J =175°C	
VGE(th)	Gate Threshold Voltage	4.5	_	6	V	Ic=1.7mA,Vc==Vg=	
Ices	Collector-Emitter Leakage Current	_	_	200	μA	Vge =0V,Vce=1200V	
lone	Gate to Emitter Reverse Leakage	_	_	200	ъ Л	Vge=25V,Vce =0V	
IGES	Gate to Emitter Reverse Leakage	_	_	-200	nA	Vge=-25V,Vce =0V	
Cies	Input capacitance		4720	_		V _{GS} = 0V	
Coes	Output capacitance		110	_	pF	V _{DS} = 50V	
Cres	Reverse transfer capacitance		70	_		f = 1MHz	
t _{d(on)}	Turn-on delay time	_	42	_		V _{CC} =600V,	
t _r	Rise time	_	25	_	-	V _{GE} =0.0/15.0V,	
t _{d(off)}	Turn-Off delay time	_	360	_	ns	$R_G=10.0\Omega$, $L_\sigma=90$ nH,	
t _f	Fall time		54	_	-	C_{σ} =67pF	
Eon	Turn-On Switching Loss		3.2			V _{CC} =600V,	
Lon	rum-on ownorming 2000		0.2			V _{GE} =0.0/15.0V,	
Eoff	Turn-Off Switching Loss	_	2.35	_	mJ	$R_G=10.0\Omega$,	
	-				-	L _σ =90nH,	
Ets	Total Switching Loss	_	5.55	_		C _σ =67pF	
Qg	Total Gate Charge	_	240	_		\/oo=490\/ lo=50A	
Qge	Gate to Emitter Charge		42	_	nC	Vcc=480V, Ic=50A, Vg==15V	
Qgc	Gate to Collector Charge	_	138	_		VGE-10V	

Electrical Characteristics of the Diode@T_A=25°C unless otherwise specified

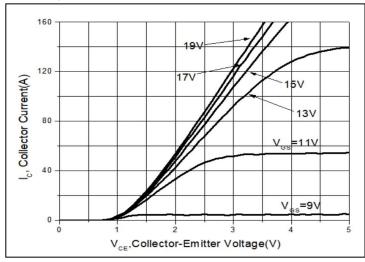
Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions	
VFM	Diode Forward Voltage	_	2.4	3	V	I _F =50A,V _{GE} =0V	
t _{rr}	Reverse Recovery Time	_	225	_	ns		
Qrr	Reverse Recovery Charge	_	2.8	_	μC	T _J = 25°C, I _F =50A, di/dt =	
Diode Peak Reverse Red Current	Diode Peak Reverse Recovery	overy	00	— А		700A/µs	
	Current	_	29				

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Typical Electrical and Thermal Characteristics



25° C

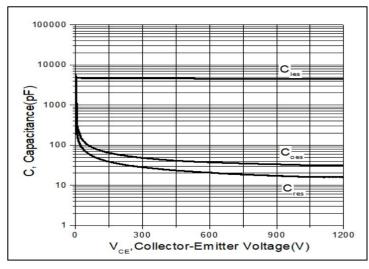
(V)

120

150° C

Figure 1. Typical Output Characteristics





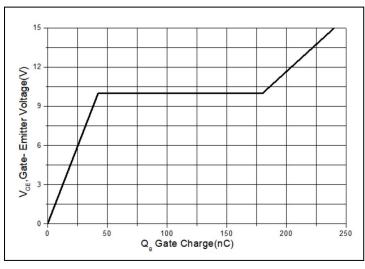


Figure 3. Typical Capacitance

P_D, Power Dissipation(W)

Figure 4. Typical Gate Charge

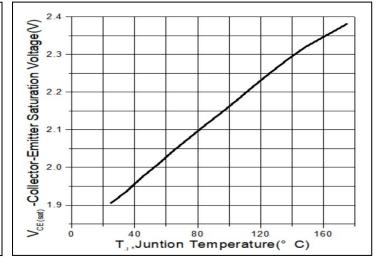


Figure 5. Power Dissipation vs. Case Temperature

T_c, Case Temperature(°C)

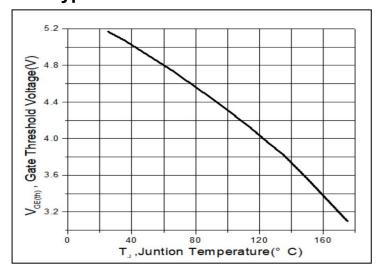
100

Figure 6. Collector-Emitter Saturation Voltage vs. Temperature





Typical Electrical and Thermal Characteristics



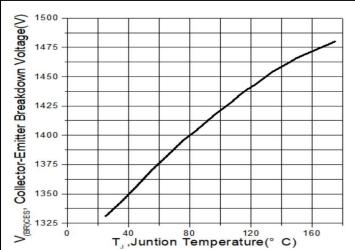


Figure 7. Gate Threshold Voltage vs. Temperature

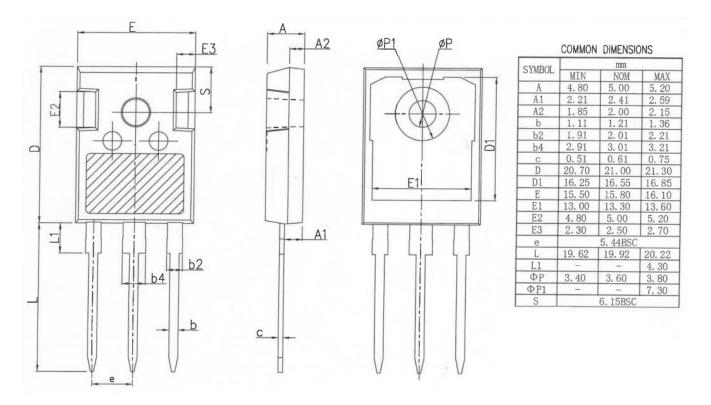
Figure 8. Collector-Emitter Breakdown Voltage vs. Temperature





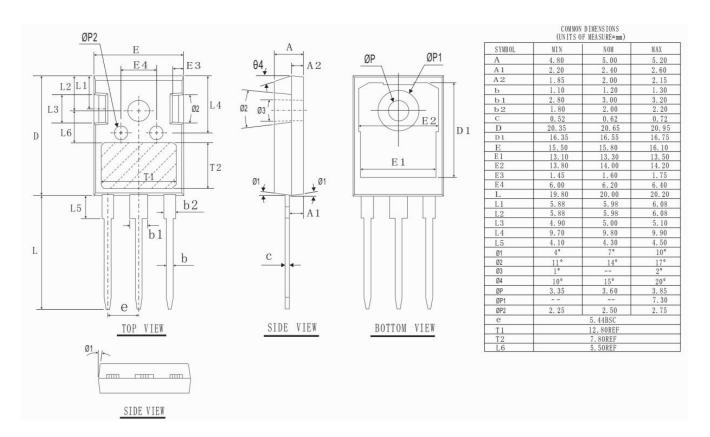
Mechanical Data:

Option1:





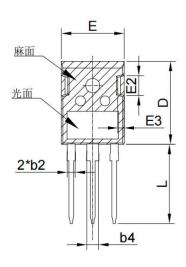
Option2:

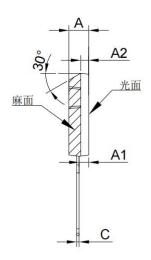


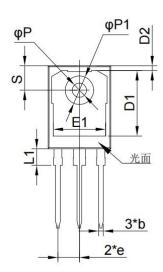


Option3:

Unit:mm







	Min	Тур	Max		Min	Тур	Max
Α	4.7	5.00	5.20	E1	13.2	13.5	13.8
A1	2.30	2.40	2.50	E2	4.90	5.00	5.10
A2	1.90	2.00	2.10	E3	1.50	1.60	1.70
b	1.10	1.20	1.30	е	5.34	5.44	5.54
b2	1.80	2.00	2.20	L,	19.80	20.00	20.32
b4	2.80	3.00	3.20	L1		4.17	4.50
С	0.5	0.6	0.7	Р	3.50	3.60	3.70
D	20.8	20.95	21.1	P1	7.00	7.19	7.40
D1	16.25	16.55	16.85	S	6.04	6.15	6.3
D2	0.95	1.17	1.35				
E	15.48	15.88	16.28				





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